Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/088,503	YAMANAKA ET AL.	
Examiner	Art Unit	
Tran O. Le	2633	

	SEARCHED				
Class	Subclass	Date	Examiner		
398	1-214	3/1/2005	TQL		
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INI	ERFERENC	ENCE SEARCHED		
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY))
		DATE	EXMR
Inventors		3/1/2005	TQL
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